#### **PRELIMINARY** July 1989

# DM54LS450/DM74LS450 16:1 Multiplexer

### **General Description**

The 16:1 Mux selects one of sixteen inputs, E0 through E15, specified by four binary select inputs, A, B, C, and D. The true data is output on Y and the inverted data on W. Propagation delays are the same for both inputs and addresses and are specified for 50 pF loading. Outputs conform to the standard 8 mA LS totem pole drive standard.

#### Features/Benefits

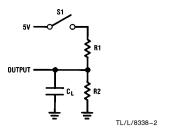
- 24-pin SKINNYDIP saves space
- Similar to 74150 (Fat DIP)
- Low current PNP inputs reduce loading

### **Connection Diagram**

## **Top View** W E15 E14 E13 E12 E11 18 17 16 15 W E15 E14 E13 E12 E3 E4 E5 E6 E7 E8 E9 E10 E9 E10 GND Ė2 Ē5 Ē7 E8 TL/L/8338-1

Order Number DM54LS450J, DM74LS450J, DM74LS450N or DM74LS450V See NS Package Number J24F, N24C or V28A

### **Standard Test Load**



### **Function Table**

	In <sub>l</sub> Sel	Output					
D	С	В	Α	A W			
L	L	L	L	E0	E0		
L	L	L	Н	E1	E1		
L	L	Н	L	E2	E2		
L	L	Н	Н	E3	E3		
L	Н	L	L	E4	E4		
L	Н	L	Н	E5	E5		
L	Н	Н	L	<u>E6</u>	E6		
L	Н	Н	Н	E7	E7		
Н	L	L	L	E8	E8		
Н	L	L	Н	E9	E9		
Н	L	Н	L	E10	E10		
Н	L	Н	Н	E11	E11		
Н	Н	L	L	E12	E12		
Н	Н	L	Н	E13	E13		
Н	Н	Н	L	E14	E14		
Н	Н	Н	Н	E15	E15		

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### **Absolute Maximum Ratings**

If Military/Aerospace specified devices are required, please contact the National Semiconductor Sales Office/Distributors for availability and specifications.

Supply Voltage V<sub>CC</sub> Input Voltage 5.5V Off-State Output Voltage  $-65^{\circ}$  to  $+150^{\circ}$ C Storage Temperature

5.5V

## **Operating Conditions**

Symbol	Parameter		Military			Units		
	i didilicitei	Min	Nom	Max	Min	Nom	Max	Cints
V <sub>CC</sub>	Supply Voltage	4.5	5	5.5	4.75	5	5.25	V
T <sub>A</sub>	Operating Free-Air Temperature	-55		125*	0		75	°C

<sup>\*</sup>Case temperature

## Electrical Characteristics Over Operating Conditions

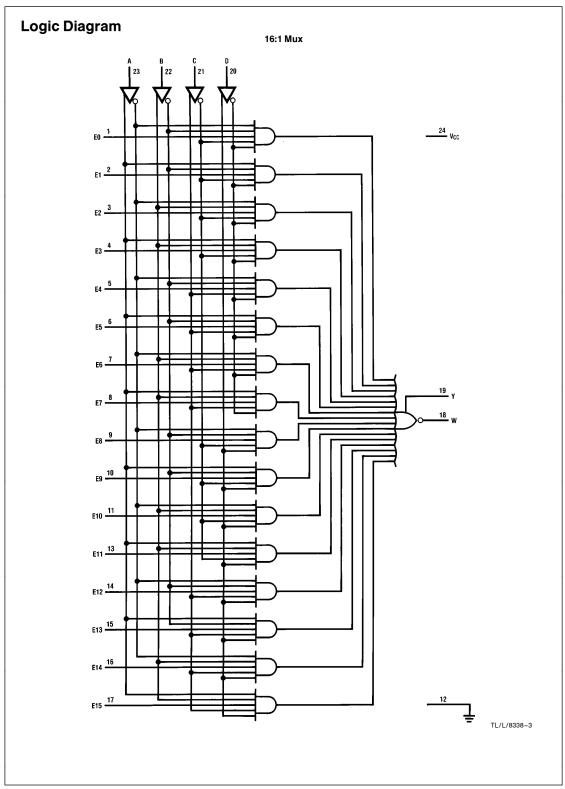
Symbol	Parameter	Test Conditions			Min	Тур†	Max	Units
V <sub>IL</sub>	Low-Level Input Voltage						0.8	V
V <sub>IH</sub>	High-Level Input Voltage				2			٧
V <sub>IC</sub>	Input Clamp Voltage	V <sub>CC</sub> =MIN	$I_1 = -18 \text{ mA}$				-1.5	٧
I <sub>IL</sub>	Low-Level Input Current	V <sub>CC</sub> =MAX	$V_I = 0.4V$				-0.25	mA
I <sub>IH</sub>	High-Level Input Current	V <sub>CC</sub> =MAX	$V_1 = 2.4V$				25	μΑ
- I <sub>I</sub>	Maximum Input Current	V <sub>CC</sub> =MAX	$V_1 = 5.5V$				1	mA
V <sub>OL</sub>	Low-Level Output Voltage	$V_{CC} = MIN$ $V_{IL} = 0.8V$ $V_{IH} = 2V$		I <sub>OL</sub> =8 mA			0.5	V
V <sub>OH</sub>	High-Level Output Voltage	V <sub>CC</sub> =MIN V <sub>IL</sub> =0.8V	MIL	I <sub>OH</sub> = -2 mA	2.4			V
		V <sub>IH</sub> =2V	СОМ	$I_{OH}$ = $-3.2 \text{ mA}$				
Ios	Output Short-Circuit Current*	V <sub>CC</sub> =5.0V		$V_O = 0V$	-30		<b>-130</b>	mA
Icc	Supply Current	V <sub>CC</sub> =MAX				60	100	mA

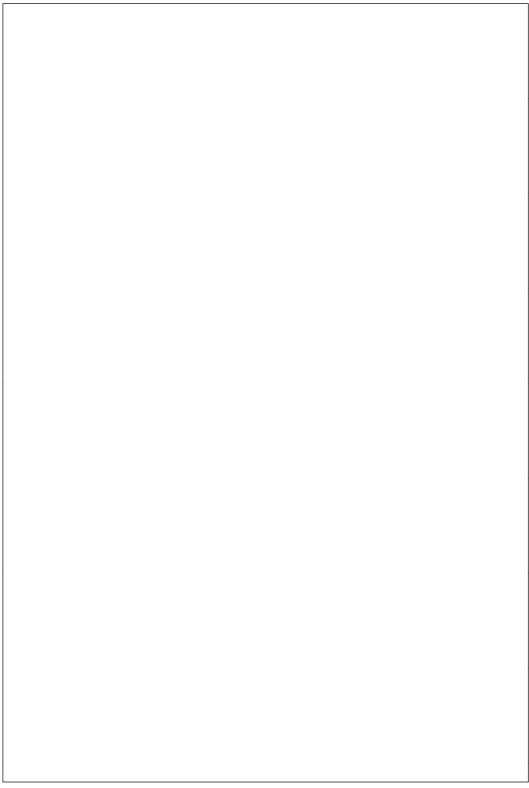
<sup>\*</sup>No more than one output should be shorted at a time and duration of the short-circuit should not exceed one second.

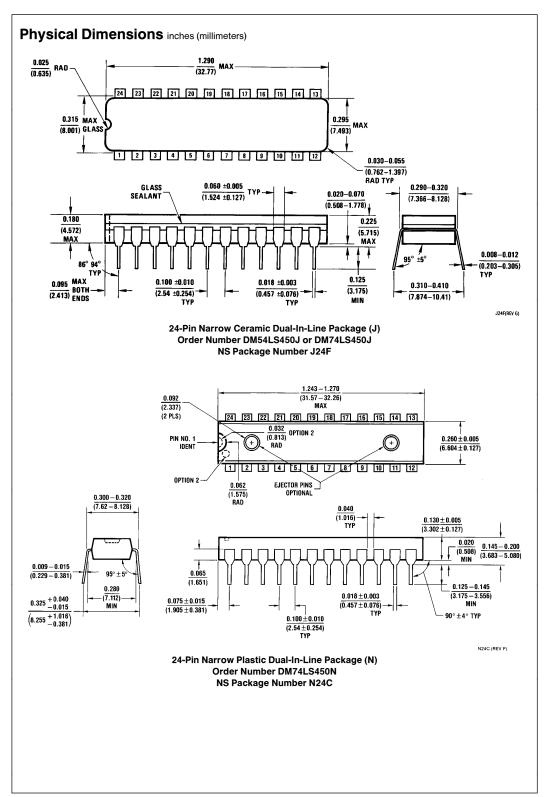
## Switching Characteristics Over Operating Conditions

Symbol	Parameter	Test Conditions (See Test Load)	Military			Commercial			Units
			Min	Тур	Max	Min	Тур	Max	Oilles
t <sub>PD</sub>	Any Input to Y or W	$C_L = 50 \text{ pF}$ $R_1 = 560\Omega$ $R_2 = 1.1 \text{k}\Omega$		25	45		25	40	ns

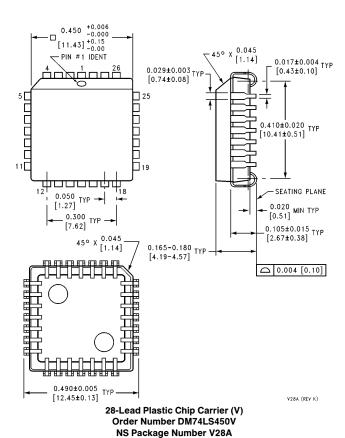
<sup>†</sup>All typical values are at  $V_{CC} = 5V$ ,  $T_A = 25$ °C.







### Physical Dimensions inches (millimeters) (Continued)



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